

# UNISONIC TECHNOLOGIES CO., LTD

# MJE13003

## NPN SILICON TRANSISTOR

## **NPN SILICON POWER TRANSISTOR**

## **DESCRIPTION**

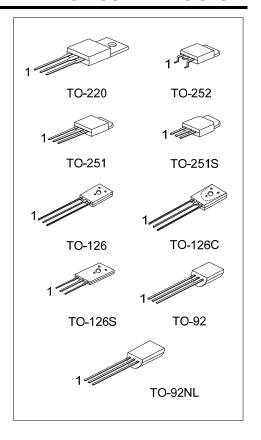
These devices are designed for high-voltage, high-speed power switching inductive circuits where fall time is critical. They are particularly suited for 115 and 220V applications in switch mode.

## **FEATURES**

- \* Reverse biased SOA with inductive load @ T<sub>C</sub>=100°C
- \* Inductive switching matrix 0.5 ~ 1.5 Amp, 25 and 100°C Typical  $t_C$  = 290ns @ 1A, 100°C.
- \* 700V blocking capability

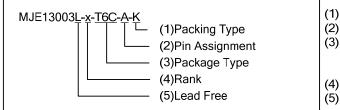
## **APPLICATIONS**

- \* Switching regulator's, inverters
- \* Motor controls
- \* Solenoid/relay drivers
- \* Deflection circuits



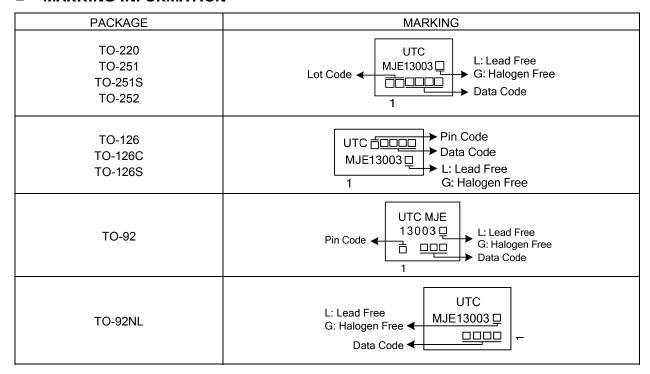
## ■ ORDERING INFORMATION

Orderin	g Number	Dookogo	Pin	Assignr	Dooking	
Lead Free	Halogen-Free	Package	1	2	3	Packing
MJE13003L-x-TA3-T	MJE13003G-x-TA3-T	TO-220	В	С	Е	Tube
MJE13003L-x-TM3-T	MJE13003G-x-TM3-T	TO-251	В	С	Е	Tube
MJE13003L-x-TMS-T	MJE13003G-x-TMS-T	TO-251S	В	С	Е	Tube
MJE13003L-x-TN3-T	MJE13003G-x-TN3-T	TO-252	В	С	Е	Tube
MJE13003L-x-TN3-R	MJE13003G-x-TN3-R	TO-252	В	С	Е	Tape Reel
MJE13003L-x-T60-K	MJE13003G-x-T60-K	TO-126	В	С	Е	Bulk
MJE13003L-x-T6C-A-K	MJE13003G-x-T6C-A-K	TO-126C	Е	С	В	Bulk
MJE13003L-x-T6C-K	MJE13003G-x-T6C-K	TO-126C	В	С	Е	Bulk
MJE13003L-x-T6S-K	MJE13003G-x-T6S-K	TO-126S	В	С	Е	Bulk
MJE13003L-x-T92-B	MJE13003G-x-T92-B	TO-92	Е	С	В	Tape Box
MJE13003L-x-T92-K	MJE13003G-x-T92-K	TO-92	Е	С	В	Bulk
MJE13003L-x-T92-F-B	MJE13003G-x-T92-F-B	TO-92	В	С	Е	Tape Box
MJE13003L-x-T92-F-K	MJE13003G-x-T92-F-K	TO-92	В	С	Е	Bulk
MJE13003L-x-T9N-B	MJE13003G-x-T9N-B	TO-92NL	Е	С	В	Tape Box
MJE13003L-x-T9N-K	MJE13003G-x- T9N-K	TO-92NL	Е	С	В	Bulk



- (1) B: Tape Box, K: Bulk, R: Tape Reel, T: Tube
- (2) refer to Pin Assignment (for TO-126C)
- (3) TA3: TO-220, TM3: TO-251, TMS: TÓ-251S, TN3: TO-252, T60: TO-126, T6C:TO-126C, T6S: TO-126S, T92: TO-92, T9N: TO-92NL
- (4) x: refer to Classification of hFE1
- (5) L: Lead Free, G: Halogen Free

## **■ MARKING INFORMATION**



## ■ ABSOLUTE MAXIMUM RATINGS

PARAMETER			SYMBOL	RATINGS	UNIT
Collector-Emitter Voltage			V <sub>CEO(SUS)</sub>	400	V
Collector-Base Voltage			$V_{CBO}$	700	V
Emitter Base Voltag	ge		$V_{EBO}$	9	V
Callantan Commant		Continuous	Ic	1.5	
Collector Current		Peak (1)	I <sub>CM</sub>	3	A
Dago Current		Continuous	I <sub>B</sub>	0.75	
Base Current		Peak (1)	I <sub>BM</sub>	1.5	A
Finalities of Commonst		Continuous	Ι <sub>Ε</sub>	2.25	
Emitter Current		Peak (1)	I <sub>EM</sub>	4.5	A
		TO-126/TO-126C TO-126S		1.4	W
	T 0500	TO-92/TO-92NL	]	1.1	W
	T <sub>A</sub> =25°C	TO-220	_	2	W
Dower Dissipation		TO-251/TO-251S TO-252		1.56	W
Power Dissipation	T <sub>C</sub> =25°C	TO-126/TO-126C TO-126S	P <sub>D</sub>	20	W
		TO-92/TO-92NL		1.5	W
		TO-220		40	W
		TO-251/TO-251S TO-252		25	W
Junction Temperature			TJ	+150	°C
Storage Temperature			T <sub>STG</sub>	-55 ~ <b>+</b> 150	°C

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

## ■ **ELECTRICAL CHARACTERISTICS** (T<sub>C</sub>=25°C, unless otherwise specified.)

PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT		
OFF CHARACTERISTICS (Note)									
Collector-Emitter Sustaining Voltage		V <sub>CEO(SUS)</sub>	I <sub>C</sub> =10mA , I <sub>B</sub> =0	400			V		
	T <sub>C</sub> =25°C	_	V <sub>CEO</sub> =Rated Value,			1			
Collector Cutoff Current	T <sub>C</sub> =100°C	I <sub>CEO</sub>	V <sub>BE(OFF)</sub> =1.5 V			5	mA		
Emitter Cutoff Current	-	I <sub>EBO</sub>	V <sub>EB</sub> =9V, I <sub>C</sub> =0		1	mA			
SECOND BREAKDOWN			•						
Second Breakdown Collector Current	with bass	ls/b		See Fig.5					
forward biased									
Clamped Inductive SOA with base rev	erse biased	RB <sub>SOA</sub>		See Fig.6					
ON CHARACTERISTICS (Note)		_		=.	-	-			
DC Current Gain		h <sub>FE1</sub>	I <sub>C</sub> =0.5A, V <sub>CE</sub> =5V	14 57 5 30		57			
DC Current Gain		h <sub>FE2</sub>	I <sub>C</sub> =1A, V <sub>CE</sub> =5V			30			
			I <sub>C</sub> =0.5A, I <sub>B</sub> =0.1A			0.5			
Collector-Emitter Saturation Voltage		\/	I <sub>C</sub> =1A, I <sub>B</sub> =0.25A			1	V		
		V <sub>CE(SAT)</sub>	I <sub>C</sub> =1.5A, I <sub>B</sub> =0.5A			3			
			I <sub>C</sub> =1A, I <sub>B</sub> =0.25A, T <sub>C</sub> =100°C			1			
Base-Emitter Saturation Voltage		V <sub>BE(SAT)</sub>	I <sub>C</sub> =0.5A, I <sub>B</sub> =0.1A			1			
			I <sub>C</sub> =1A, I <sub>B</sub> =0.25A			1.2	V		
		` ,	I <sub>C</sub> =1A, I <sub>B</sub> =0.25A, T <sub>C</sub> =100°C			1.1	1		
DYNAMIC CHARACTERISTICS				_	_	_			
Current-Gain-Bandwidth Product		f⊤	I <sub>C</sub> =100mA, V <sub>CE</sub> =10V, f=1MHz	4	10		MHz		
Output Capacitance		Сов	V <sub>CB</sub> =10V, I <sub>E</sub> =0, f=0.1MHz		21		pF		
SWITCHING CHARACTERISTICS									
Resistive Load (Table 1)				-					
Delay Time		$t_D$			0.05	0.1	μs		
Rise Time		$t_{R}$	V <sub>CC</sub> =125V, I <sub>C</sub> =1A, <sub>B1</sub> =I <sub>B2</sub> =0.2A,		0.5	1	μs		
Storage Time		ts	t <sub>P</sub> =25µs, Duty Cycle≤1%		2	4	μs		
Fall Time		$t_{F}$			0.4	0.7	μs		
Inductive Load, Clamped (Table 1)									
Storage Time		t <sub>STG</sub>	-1 -14 \/ -200\/ 1 -0.24		1.7	4	μs		
Crossover Time		$t_{C}$	I <sub>C</sub> =1A, V <sub>CLAMP</sub> =300V, I <sub>B1</sub> =0.2A, V <sub>BE(OFF)</sub> =5V <sub>DC</sub> , T <sub>C</sub> =100°C		0.29	0.75	μs		
Fall Time	t <sub>F</sub>	VBE(OFF)=3 VDC, 1C=100 C		0.15		μs			
Note: Dules Test: DW-200us Duty Co	Note: Pulsa Tast: PW-300us, Duty Cycle<2%								

Note: Pulse Test: PW=300µs, Duty Cycle≤2%

## ■ CLASSIFICATION OF h<sub>FE1</sub>

RANK	Α	В	С	D	Е	F	G	Н
RANGE	14 ~ 22	21 ~ 27	26 ~ 32	31 ~ 37	36 ~ 42	41 ~ 47	46 ~ 52	51 ~ 57

## APPLICATION INFORMATION

Table 1.Test Conditions for Dynamic Performance

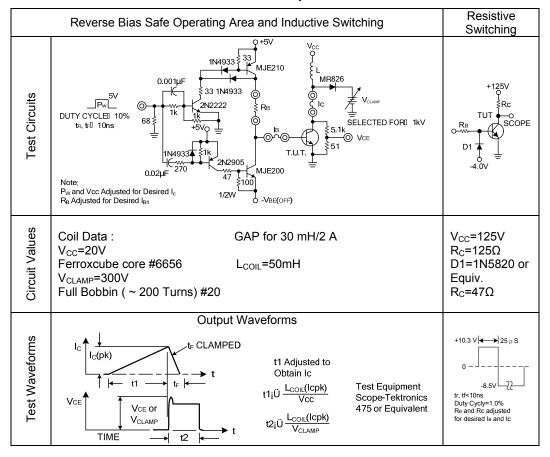


Table 2. Typical Inductive Switching Performance

Ic	Tc	t <sub>sv</sub>	t <sub>RV</sub>	t <sub>FI</sub>	t <sub>TI</sub> (µs)	tc
(A)	(°C)	(µs)	(µs)	(µs)		(µs)
0.5	25	1.3	0.23	0.30	0.35	0.30
	100	1.6	0.26	0.30	0.40	0.36
1	25	1.5	0.10	0.14	0.05	0.16
	100	1.7	0.13	0.26	0.06	0.29
1.5	25	1.8	0.07	0.10	0.05	0.16
	100	3	0.08	0.22	0.08	0.28

Note: All Data Recorded in the Inductive Switching Circuit in Table 1

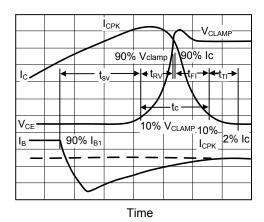


Fig.1 Inductive Switching Measurements

## **■ SWITCHING TIMES NOTE**

In resistive switching circuits, rise, fall, and storage times have been defined and apply to both current and voltage waveforms since they are in phase. However, for inductive loads, which are common to switch mode power supplies and hammer drivers, current and voltage waveforms are not in phase. Therefore, separate measurements must be made on each waveform to determine the total switching time. For this reason, the following new terms have been defined.

 $t_{SV}$  = Voltage Storage Time, 90%  $I_{B1}$  to 10%  $V_{CLAMP}$ 

 $t_{RV}$  = Voltage Rise Time, 10 ~ 90%  $V_{CLAMP}$ 

 $t_{FI}$ = Current Fall Time, 90 ~ 10%  $I_{C}$ 

 $t_{TI}$  = Current Tail, 10 ~ 2%  $I_{C}$ 

 $t_C$  = Crossover Time, 10%  $V_{CLAMP}$  to 10%  $I_C$ 

For the designer, there is minimal switching loss during storage time and the predominant switching power losses occur during the crossover interval and can be obtained using the standard equation:

$$P_{SWT} = 1/2 V_{CC}I_{C} (t_{C}) f$$

In general,  $t_{RV} + t_{FI} \approx t_C$ . However, at lower test currents this relationship may not be valid.

As is common with most switching transistors, resistive switching is specified at 25°C and has become a benchmark for designers. However, for designers of high frequency converter circuits, the user oriented specifications which make this transistor are the inductive switching speeds ( $t_C$  and  $t_{SV}$ ) which are guaranteed at  $100^{\circ}C$ .

#### RESISTIVE SWITCHING PERFORMANCE

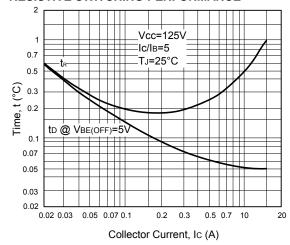


Fig.2 Turn-On Time

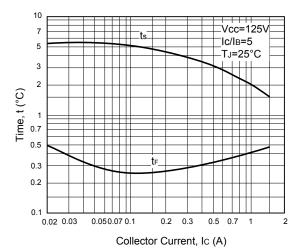


Fig.3 Turn-Off Time

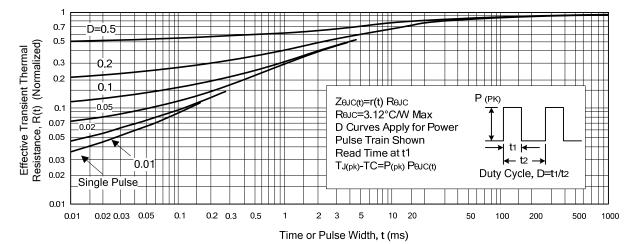


Fig.4 Thermal Response

#### SAFE OPERATING AREA INFORMATION

#### **FORWARD BIAS**

There are two limitations on the power handling ability of a transistor: average junction temperature and second breakdown. Safe operating area curves indicate  $I_C$ - $V_{CE}$  limits of the transistor that must be observed for reliable operation; i.e., the transistor must not be subjected to greater dissipation than the curves indicate.

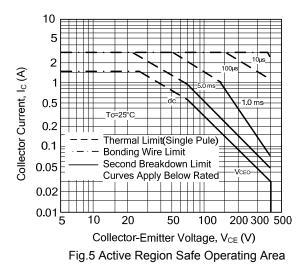
The data of Fig.5 is based on  $T_C = 25^{\circ}C$ ;  $T_{J(PK)}$  is variable depending on power level. Second breakdown pulse limits are valid for duty cycles to 10% but must be derated when  $T_C \ge 25^{\circ}C$ . Second breakdown limitations do not derate the same as thermal limitations. Allowable current at the voltages shown on Fig.5.

 $T_{J(PK)}$  may be calculated from the data in Fig.4. At high case temperatures, thermal limitations will reduce the power that can be handled to values less than the limitations imposed by second breakdown.

#### **REVERSE BIAS**

For inductive loads, high voltage and high current must be sustained simultaneously during turn-off, in most cases, with the base to emitter junction reverse biased. Under these conditions the collector voltage must be held to a safe level at or below a specific value of collector current. This can be accomplished by several means such as active clamping, RC snubbing, load line shaping, etc. The safe level for these devices is specified as  $RB_{SOA}$  (Reverse Bias Safe Operating Area) and represents the voltage-current conditions during reverse biased turn-off. This rating is verified under clamped conditions so that the device is never subjected to an avalanche mode. Fig.6 gives  $RB_{SOA}$  characteristics.

The Safe Operating Area of Fig.5 and 6 are specified ratings (for these devices under the test conditions shown.)



1.6

VBE(OFF)=9V

0.8

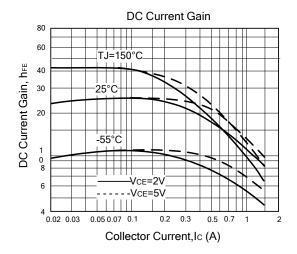
IB1=1A

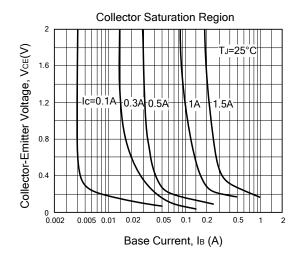
0 100 200 300 400 500 600 700 800

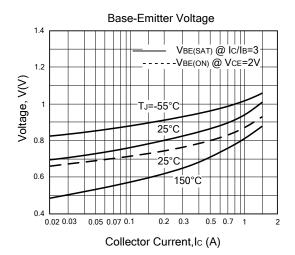
Collector-Emitter Clamp Voltage, V<sub>CE</sub> (V)

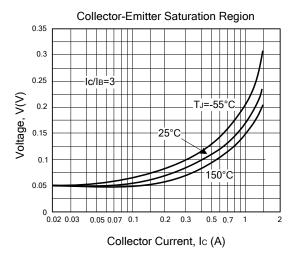
Fig. 6 Reverse Bias Safe Operating Area

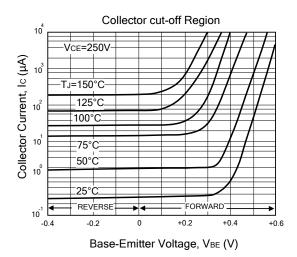
## **■ TYPICAL CHARACTERISTICS**

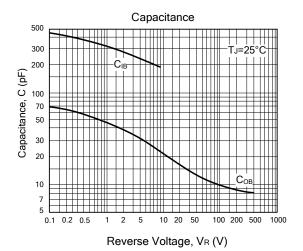




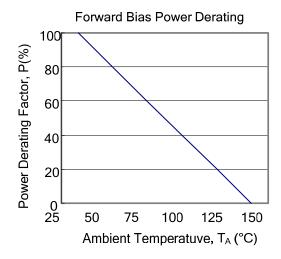








## **■ TYPICAL CHARACTERISTICS(Cont.)**



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